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Application/Control No.	Applicant(s)/Patent under. Reexamination	
09/820,395	CHEN ET AL.	
Examiner	Art Unit	
Dmitry Levitan	2662	

SEARCHED			
Class	Subclass	Date	Examiner
370	352- 356		
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379	225	7/2	
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INT	INTERFERENCE SEARCHED			
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370	353	2	カノ	
379	225	17/20/05		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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